

**Notice of References Cited**

Application/Control No.

10/750,436

Applicant(s)/Patent Under  
Reexamination  
DEB ET AL.

Examiner

MARK A. FLEISCHER

Art Unit

3624

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0002988 A1	01-2004	Seshadri et al.	707/102
*	B	US-7,236,950 B2	06-2007	Savage et al.	705/34
*	C	US-7,107,285 B2	09-2006	von Kaenel et al.	1/1
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	A text (pdf) copy of US 7107285 B2 to facilitate navigation using a paragraph numbering scheme.
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